

Single P-Channel MOSFET

■ DESCRIPTION

SMC5455H is the P-Channel MOSFET, uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge. With the excellent thermal resistance, the TO-252 package, this device is well suited for high current applications.

■ PART NUMBER INFORMATION

SMC 5455 H - TR G

a b c d e

a : Company name.

b : Product Serial number.

c : Package code H:TO-252

d : Handling code TR:Tape&Reel

e : Green produce code G:RoHS Compliant

■ FEATURES

$V_{DS}=-40V, I_D=-42A$

$R_{DS(ON)}=12.5m\Omega(\text{Typ.}) @ V_{GS}=-10V$

$R_{DS(ON)}=16m\Omega(\text{Typ.}) @ V_{GS}=-4.5V$

◆ 100% UIS and R_g tested

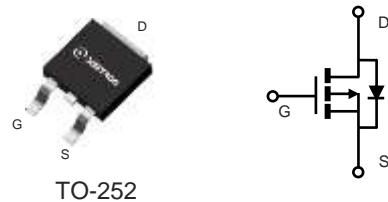
◆ High power and current handling capability

■ APPLICATIONS

◆ Load Switch

◆ Power Management

◆ Motor Drives



■ ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ Unless otherwise noted)

Symbol	Parameter	Rating	Units	
V_{DSS}	Drain-Source Voltage	-40	V	
V_{GSS}	Gate-Source Voltage	± 25	V	
I_D	Continuous Drain Current	$T_c=25^\circ\text{C}$	-42	A
		$T_c=100^\circ\text{C}$	-26.5	A
I_{DM}	Pulsed Drain Current ^B	-168	A	
I_D	Continuous Drain Current	$T_A=25^\circ\text{C}$	-15	A
		$T_A=70^\circ\text{C}$	-12	A
P_D	Power Dissipation ^A	$T_A=25^\circ\text{C}$	6.3	W
		$T_A=70^\circ\text{C}$	4	W
I_{AS}	Avalanche Current ^B	-35	A	
E_{AS}	Single Pulse Avalanche energy $L=0.1\text{mH}$ ^B	61	mJ	
P_D	Power Dissipation ^C	$T_c=25^\circ\text{C}$	48	W
		$T_c=100^\circ\text{C}$	19	W
T_J	Operation Junction Temperature	-55/150	°C	
T_{STG}	Storage Temperature Range	-55/150	°C	

■ THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient ^A	$t \leq 10\text{s}$	25	°C/W
	Thermal Resistance Junction to Ambient ^{AC}	Steady-State	50	
$R_{\theta JC}$	Thermal Resistance Junction to Case		2.6	

ELECTRICAL CHARACTERISTICS($T_A=25^\circ\text{C}$ Unless otherwise noted)

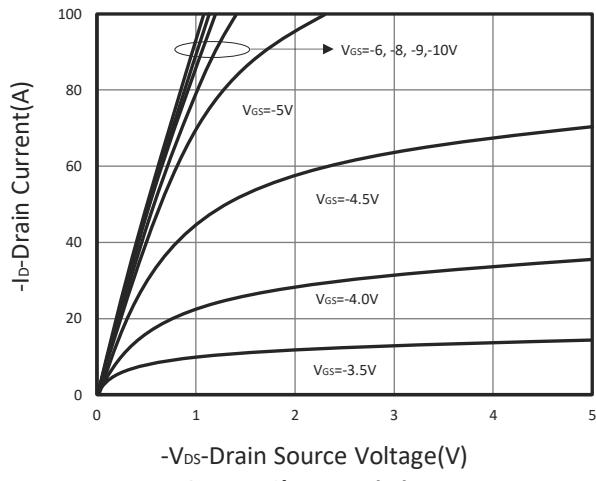
Symbol	Parameter	Condition	Min	Typ	Max	Unit	
Static Parameters							
BV_{DSS}	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=-250\mu\text{A}$	-40			V	
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=-250\mu\text{A}$	-1	-1.6	-2.5	V	
I_{GSS}	Gate Leakage Current	$\text{V}_{\text{DS}}=0\text{V}, \text{V}_{\text{GS}}=\pm 25\text{V}$			± 100	nA	
I_{DSS}	Zero Gate Voltage Drain Current	$\text{V}_{\text{DS}}=-40\text{V}, \text{V}_{\text{GS}}=0\text{V}, \text{T}_J=25^\circ\text{C}$			-1	μA	
		$\text{V}_{\text{DS}}=-32\text{V}, \text{V}_{\text{GS}}=0\text{V}, \text{T}_J=75^\circ\text{C}$			-10		
$\text{R}_{\text{DS(ON)}}$	Drain-source On-Resistance ^D	$\text{V}_{\text{GS}}=-10\text{V}, \text{I}_D=-15\text{A}$		12.5	15	$\text{m}\Omega$	
		$\text{V}_{\text{GS}}=-4.5\text{V}, \text{I}_D=-10\text{A}$		16	20		
G_{f}	Forward Transconductance	$\text{V}_{\text{DS}}=-10\text{V}, \text{I}_D=-11\text{A}$		30		S	
Diode Characteristics							
V_{SD}	Diode Forward Voltage ^D	$\text{I}_{\text{S}}=-1\text{A}, \text{V}_{\text{GS}}=0\text{V}$			-1	V	
I_{S}	Diode Continuous Forward Current				-21	A	
Dynamic and Switching Parameters^E							
Q_{g}	Total Gate Charge	$\text{V}_{\text{DS}}=-20\text{V}, \text{V}_{\text{GS}}=-10\text{V}$ $\text{I}_{\text{D}}=-11\text{A}$		40.6	54.8	nC	
Q_{g}	Total Gate Charge (4.5V)			19.8	26.7		
Q_{gs}	Gate-Source Charge			6.8	9.2		
Q_{gd}	Gate-Drain Charge			7.8	10.5		
C_{iss}	Input Capacitance	$\text{V}_{\text{DS}}=-20\text{V}, \text{V}_{\text{GS}}=0\text{V}, \text{f}=1\text{MHz}$		2050		pF	
C_{oss}	Output Capacitance			175			
C_{rss}	Reverse Transfer Capacitance			126			
R_{g}	Gate Resistance	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=0\text{V}, \text{f}=1\text{MHz}$		8.5		Ω	
$\text{t}_{\text{d(on)}}$	Turn-On Time	$\text{V}_{\text{DD}}=-20\text{V}, \text{V}_{\text{GEN}}=-10\text{V}$ $\text{R}_{\text{G}}=6\Omega \text{ I}_{\text{D}}=-1\text{A}$		17.3		nS	
				13			
$\text{t}_{\text{d(off)}}$	Turn-Off Time			70			
t_{f}				32			

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

- A. Surface mounted on FR4 board using 1 in² pad size.
- B. Pulsed width limited by maximum junction temperature, $\text{T}_J(\text{MAX})=150^\circ\text{C}$.
- C. Using $\leq 10\text{s}$ junction-to-ambient thermal resistance is base on $\text{T}_J(\text{MAX})=150^\circ\text{C}$.
- D. Pulse test width $\leq 300\mu\text{s}$ and duty cycle $\leq 2\%$.
- E. Guaranteed by design, not subject to production testing.

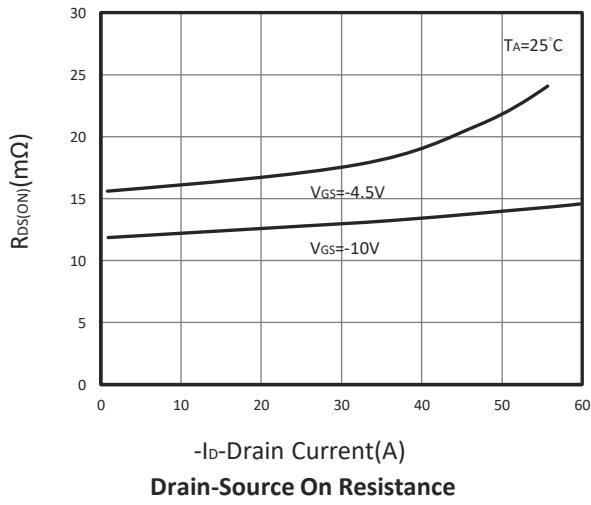
The products and product specifications contained herein are subject to change without notice to improve performance characteristics. Consult us, or our representatives before use, to confirm that the information in this datasheet is up to date. We assume no responsibility for any infringement of patents, patent rights, or other rights arising from the use of any information and circuitry in this datasheet.

TYPICAL CHARACTERISTICS



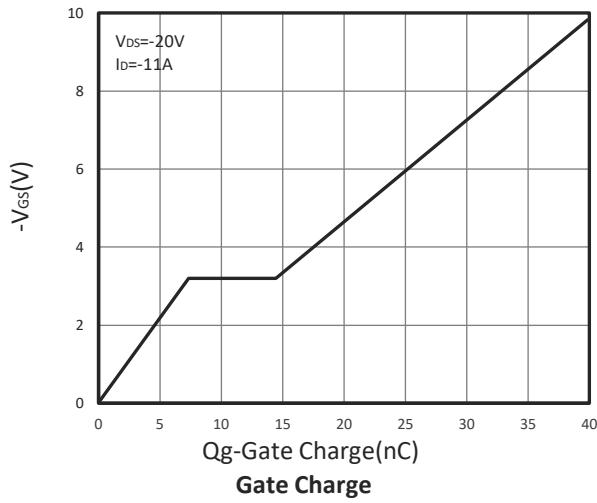
-V_{DS}-Drain Source Voltage(V)

Output Characteristics



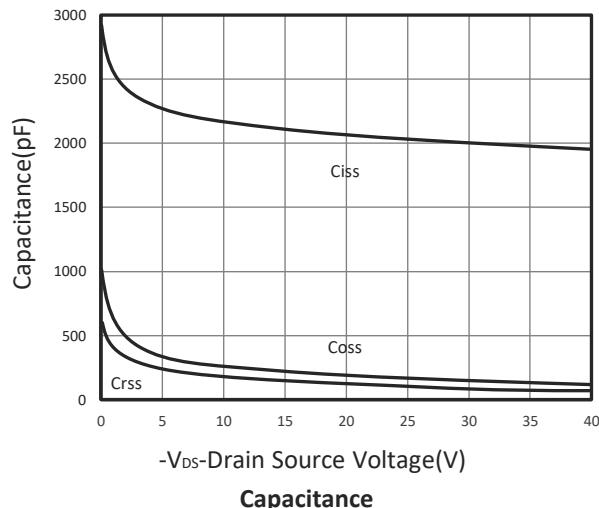
-I_D-Drain Current(A)

Drain-Source On Resistance



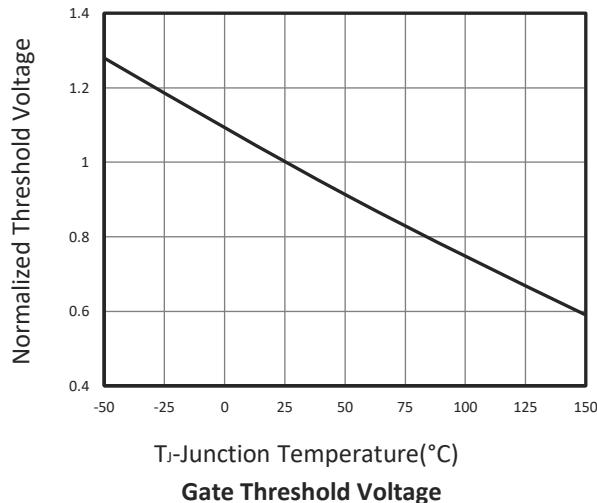
Qg-Gate Charge(nC)

Gate Charge



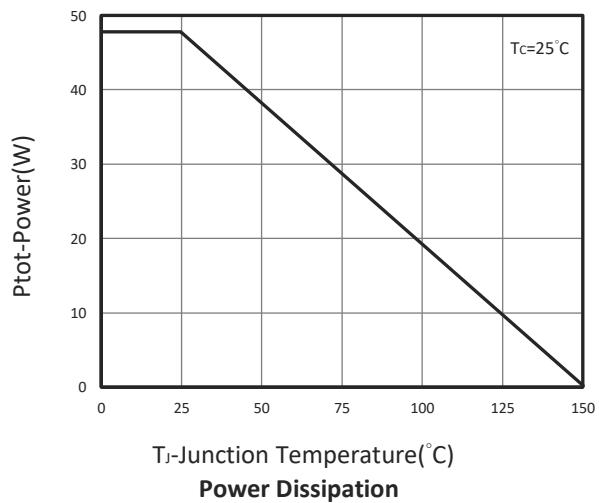
-V_{DS}-Drain Source Voltage(V)

Capacitance



T_J -Junction Temperature(°C)

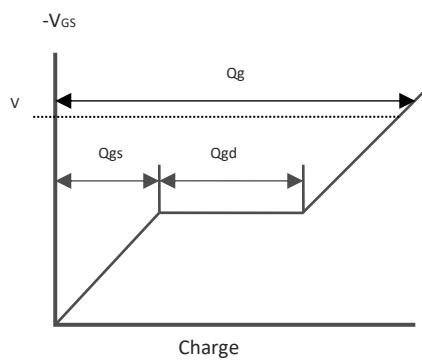
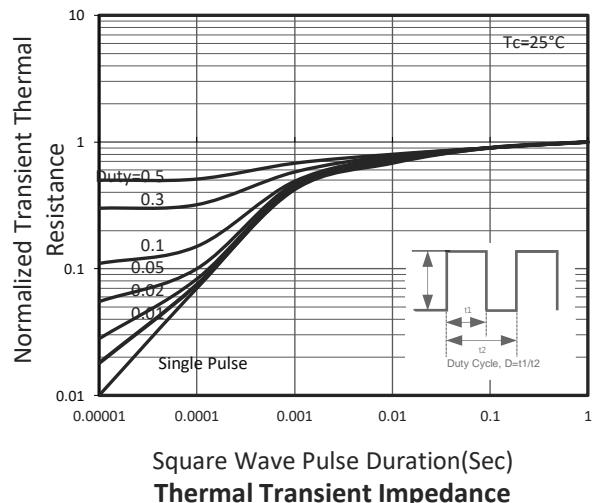
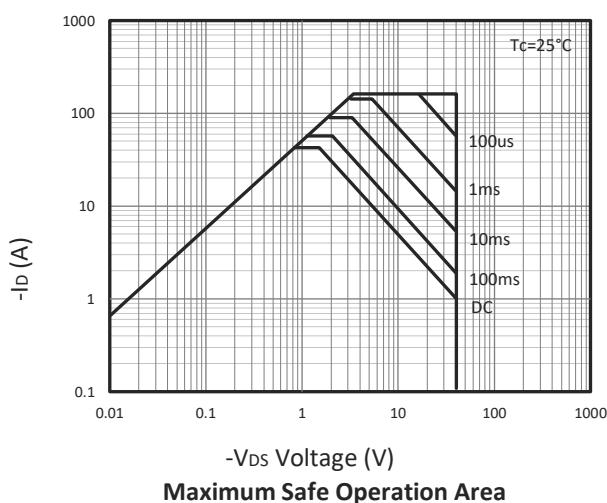
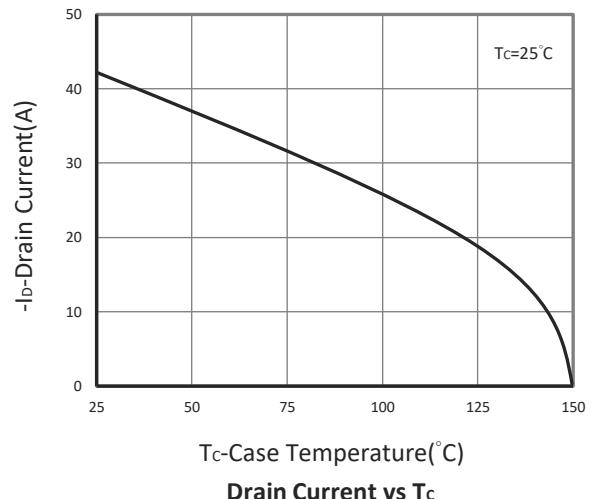
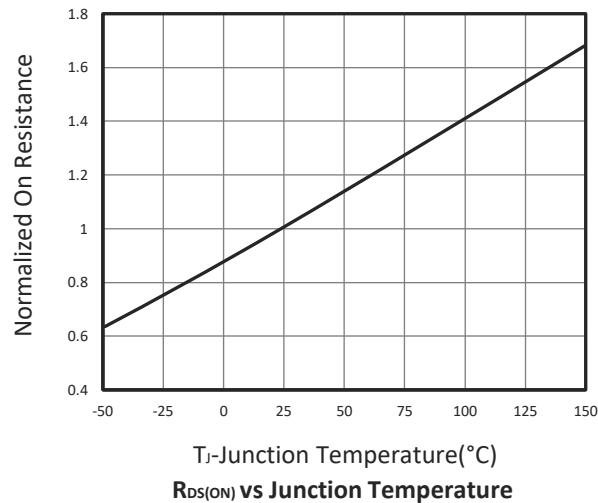
Gate Threshold Voltage



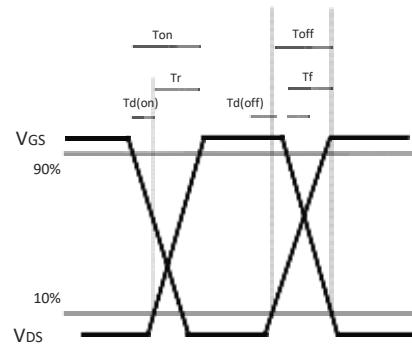
T_J -Junction Temperature(°C)

Power Dissipation

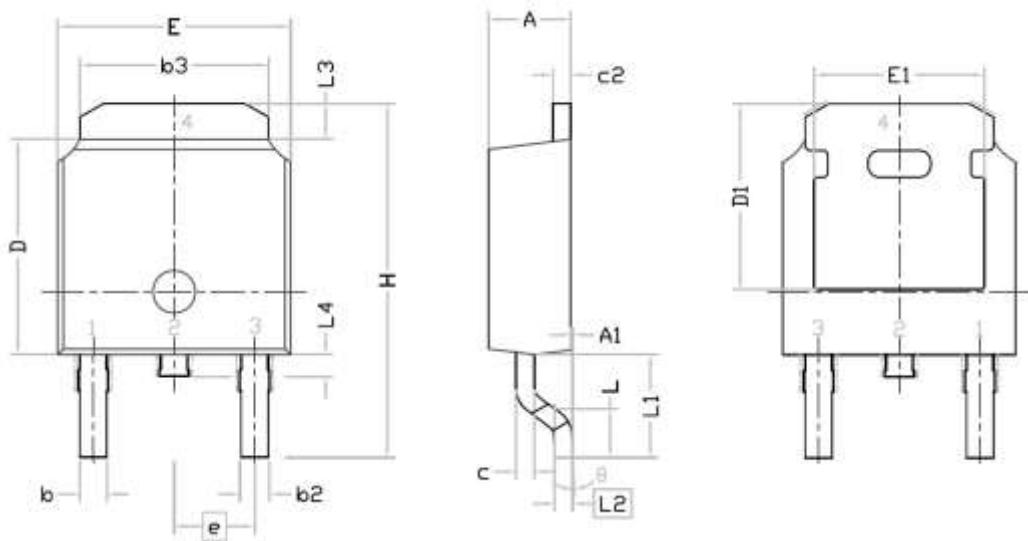
TYPICAL CHARACTERISTICS



Gate Charge Waveform



Switching Time Waveform

■ TO-252 PACKAGE DIMENSIONS


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.380	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.640	0.880	0.025	0.035
b2	0.770	1.140	0.030	0.045
b3	5.210	5.460	0.205	0.215
c	0.460	0.600	0.018	0.024
c2	0.460	0.580	0.018	0.023
D	6.000	6.223	0.236	0.245
D1	5.210	-	0.205	-
E	6.400	6.731	0.252	0.265
E1	4.400	-	0.173	-
e	2.286 BSC.		0.090 BSC.	
H	9.400	10.40	0.370	0.409
L	1.400	1.770	0.055	0.070
L1	2.743 REF.		0.108 REF.	
L2	0.508 BSC.		0.020 BSC.	
L3	0.890	1.270	0.035	0.050
L4	0.640	1.010	0.025	0.040
theta	0°	10°	0°	10°

Recommended Land Pattern

